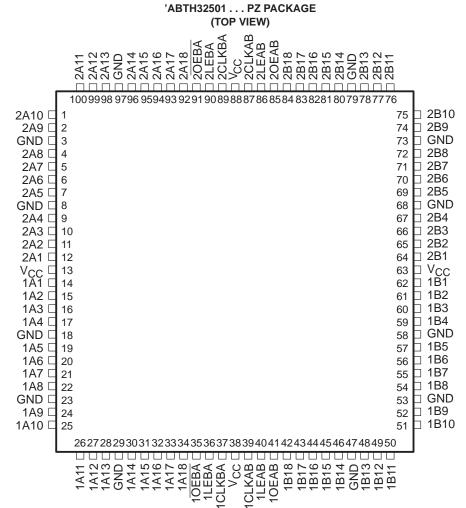
SN54ABTH32501, SN74ABTH32501 36-BIT UNIVERSAL BUS TRANSCEIVERS WITH 3-STATE OUTPUTS SCB5229F – JUNE 1992 – REVISED MAY 1997

- Members of the Texas Instruments *Widebus+*[™] Family
- State-of-the-Art *EPIC-*II*B*[™] BiCMOS Design Significantly Reduces Power Dissipation
- UBT[™] (Universal Bus Transceiver) Combines D-Type Latches and D-Type Flip-Flops for Operation in Transparent, Latched, or Clocked Mode
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Latch-Up Performance Exceeds 500 mA Per JEDEC Standard JESD-17
- Released as DSCC SMD 5962-9557601NXD

- Typical V_{OLP} (Output Ground Bounce) < 0.8 V at V_{CC} = 5 V, T_A = 25°C
- High-Impedance State During Power Up and Power Down
- Distributed V_{CC} and GND Pin Configuration Minimizes High-Speed Switching Noise
- High-Drive Outputs (–32-mA I_{OH}, 64-mA I_{OL})
- Bus Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors
- Package Options Include 100-Pin Plastic Thin Quad Flat (PZ) Package With 14 × 14-mm Body Using 0.5-mm Lead Pitch and Space-Saving 100-Pin Ceramic Quad Flat (HS) Package[†]



[†]The HS package is not production released.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

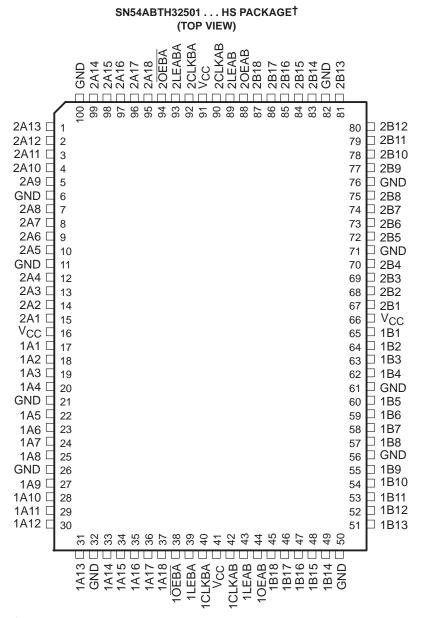
Widebus+, EPIC-IIB, and UBT are trademarks of Texas Instruments Incorporated.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



Copyright © 1997, Texas Instruments Incorporated

SCBS229F - JUNE 1992 - REVISED MAY 1997



[†] For HS package availability, please contact the factory or your local TI Field Sales Office.



description

These 36-bit UBTs combine D-type latches and D-type flip-flops to allow data flow in transparent, latched, and clocked modes.

Data flow in each direction is controlled by output-enable (OEAB and OEBA), latch-enable (LEAB and LEBA), and clock (CLKAB and CLKBA) inputs. For A-to-B data flow, the device operates in the transparent mode when LEAB is high. When LEAB is low, the A data is latched if CLKAB is held at a high or low logic level. If LEAB is low, the A data is stored in the latch/flip-flop on the low-to-high transition of CLKAB. Data flow for B to A is similar to that of A to B, but uses OEBA, LEBA, and CLKBA.

Output-enable OEAB is active high. When OEAB is high, the outputs are active. When OEAB is low, the outputs are in the high-impedance state. The output enables are complementary (OEAB is active high, and OEBA is active low).

When V_{CC} is between 0 and 2.1 V, the device is in the high-impedance state during power up or power down. However, to ensure the high-impedance state above 2.1 V, \overline{OE} should be tied to V_{CC} through a pullup resistor and OE should be tied to GND through a pulldown resistor; the minimum value of the resistor is determined by the current-sinking/current-sourcing capability of the driver.

Active bus-hold circuitry is provided to hold unused or floating data inputs at a valid logic level.

The SN54ABTH32501 is characterized for operation over the full military temperature range of –55°C to 125°C. The SN74ABTH32501 is characterized for operation from –40°C to 85°C.

FUNCTION TABLE [†]								
	OUTPUT							
OEAB	LEAB	CLKAB	Α	В				
L	Х	Х	Х	Z				
н	Н	Х	L	L				
н	Н	Х	Н	н				
н	L	\uparrow	L	L				
н	L	\uparrow	Н	н				
н	L	Н	Х	в ₀ ‡ в ₀ §				
Н	L	L	Х	в ₀ §				

[†] A-to-<u>B data</u> flow is shown: B-to-A flow is similar, but uses OEBA, LEBA, and CLKBA.

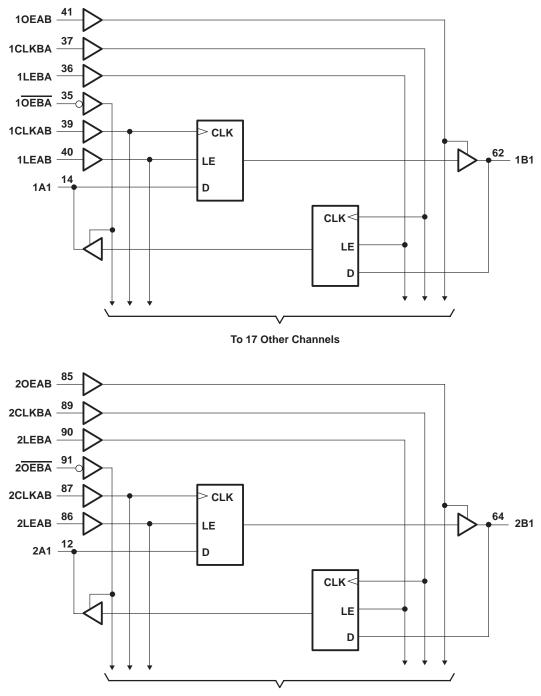
[‡]Output level before the indicated steady-state input conditions were established

§ Output level before the indicated steady-state input conditions were established, provided that CLKAB was low before LEAB went low



SN54ABTH32501, SN74ABTH32501 36-BIT UNIVERSAL BUS TRANSCEIVERS WITH 3-STATE OUTPUTS SCBS229F - JUNE 1992 - REVISED MAY 1997

logic diagram (positive logic)



To 17 Other Channels

Pin numbers shown are for the PZ package.



SCBS229F - JUNE 1992 - REVISED MAY 1997

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

2. The package thermal impedance is calculated in accordance with EIA/JEDEC Std JESD51.

recommended operating conditions (see Note 3)

					SN74ABT	UNIT	
			MIN	MAX	MIN	MAX	UNIT
VCC	Supply voltage	4.5	5.5	4.5	5.5	V	
VIH	High-level input voltage	2		2		V	
VIL	Low-level input voltage			0.8		0.8	V
VI	Input voltage			VCC	0	VCC	V
IOH	High-level output current			-24		-32	mA
IOL	Low-level output current			48		64	mA
$\Delta t/\Delta v$	Input transition rise or fall rate	Outputs enabled		10		10	ns/V
Δt/ΔV _{CC}	Power-up ramp rate		200		200		μs/V
Тд	Operating free-air temperature		-55	125	-40	85	°C

NOTE 3: Unused control pins must be held high or low to prevent them from floating.



SCBS229F - JUNE 1992 - REVISED MAY 1997

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		SN54	4ABTH3	2501	SN74	ABTH32	2501	UNIT	
PA	RAMETER	TEST CONDITIONS		MIN	TYP†	MAX	MIN	TYP [†]	MAX	UNII	
VIK		V _{CC} = 4.5 V,	lj = –18 mA			-1.2			-1.2	V	
		V _{CC} = 4.5 V,	I _{OH} = –3 mA	2.5			2.5				
Vari		V _{CC} = 5 V,	I _{OH} = -3 mA	3			3			v	
∨он		V _{CC} = 4.5 V	I _{OH} = -24 mA	2						v	
		VCC = 4.5 V	$I_{OH} = -32 \text{ mA}$				2				
VOL		V _{CC} = 4.5 V	I _{OL} = 48 mA			0.55			0.55	V	
VOL		VCC = 4.5 V	I _{OL} = 64 mA						0.55	v	
V _{hys}					100			100		mV	
	Control inputs	$V_{CC} = 0$ to 5.5 V,	$V_I = V_{CC} \text{ or } GND$						±1		
ı.	A or B ports	$V_{CC} = 2.1 V \text{ to } 5.5 V,$	$V_{I} = V_{CC} \text{ or } GND$						±20	μA	
ł	Control inputs		$V_I = V_{CC}$ or GND			±5					
	A or B ports	V _{CC} = 5.5 V,				±50					
1.4	(hold) A or B ports	V _{CC} = 4.5 V	VI = 0.8 V	100			100			μA	
II(hold) A or B ports		VCC = 4.5 V	V _I = 2 V	-100			-100			μΑ	
IOZPU‡	ŧ	$V_{CC} = 0$ to 2.1 V, $V_O = 0.5$ OE or $\overline{OE} = X$	V to 2.7 V,			±50			±50	μA	
IOZPD [‡]	ŧ	$V_{CC} = 2.1 \text{ V to 0}, V_{O} = 0.5$ OE or OE = X	V to 2.7 V,			±50			±50	μΑ	
loff		V _{CC} = 0,	$V_{I} \text{ or } V_{O} \leq 4.5 \text{ V}$						±100	μΑ	
ICEX		V _{CC} = 5.5 V, V _O = 5.5 V	Outputs high			50			50	μA	
IO§		V _{CC} = 5.5 V,	V _O = 2.5 V	-50	-100	-180	-50	-100	-180	mA	
-			Outputs high			6			6		
ICC		$V_{CC} = 5.5 \text{ V}, I_O = 0,$ $V_I = V_{CC} \text{ or GND}$	Outputs low			90			90	mA	
		Outputs disab				6			6	1	
∆lcc¶		V_{CC} = 5.5 V, One input at 3 Other inputs at V_{CC} or GNI				1			1	mA	
Ci	Control inputs	V _I = 2.5 V or 0.5 V			3.5			3.5		pF	
Cio	A or B ports	V _O = 2.5 V or 0.5 V			11.5			11.5		pF	

[†] All typical values are at $V_{CC} = 5 \text{ V}, \text{ T}_{A} = 25^{\circ}\text{C}.$

[‡] This parameter is specified by characterization.

§ Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

 \P This is the increase in supply current for each input that is at the specified TTL voltage level rather than V_{CC} or GND.

timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

				H32501	SN74ABTI	UNIT		
			MIN	MAX	MIN	MAX	UNIT	
fclock	Clock frequency		0	150	0	150	MHz	
	Pulse duration	LE high	3.5		3.3			
tw	CLK high or low		3.5		3.3		ns	
	Satur time	A or B before CLK↑	4.3		3.5		ns	
t _{su}	Setup time	A or B before LE \downarrow	2.5		1.6			
	Hold time	A or B after CLK1	0.2		0		20	
th	A or B after L		1.8		1.6		ns	



SN54ABTH32501, SN74ABTH32501 **36-BIT UNIVERSAL BUS TRANSCEIVERS** WITH 3-STATE OUTPUTS SCBS229F - JUNE 1992 - REVISED MAY 1997

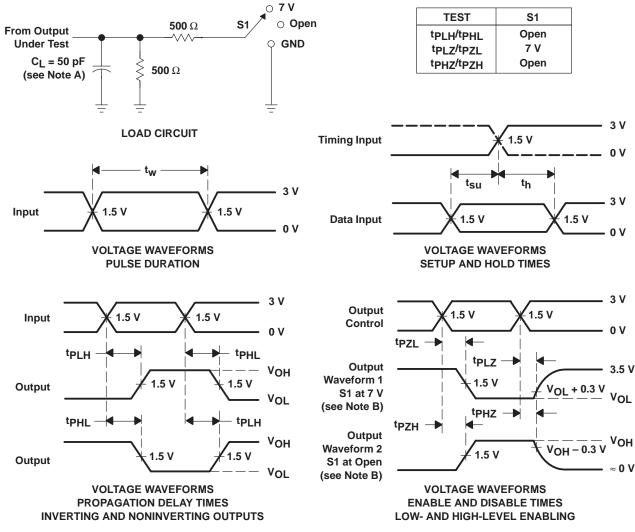
switching characteristics over recommended ranges of supply voltage and operating free-air temperature, $C_L = 50 \text{ pF}$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	SN54	SN54ABTH32501			SN74ABTH32501		
PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP [†]	MAX	MIN	TYP†	MAX	UNIT
f _{max}			150			150			MHz
^t PLH	A or B	B or A	0.5	2.9	5.2	1.3	2.9	4.8	ns
^t PHL	AUIB	BUIA	0.5	2.7	5.8	1.4	2.7	5.4	115
^t PLH	LEAB or LEBA	A or B	0.7	3.4	5.7	1.6	3.4	5.3	ns
^t PHL	LEAD OF LEDA	AUID	0.7	3.6	5.9	1.9	3.6	5.5	
^t PLH	CLKAB or CLKBA	A or B	0.5	3.2	5.7	1.5	3.2	5.3	
^t PHL	CLKAD UI CLKDA	AUB	0.7	3.3	5.8	1.7	3.3	5.4	ns
^t PZH		A or B	0.5	3.2	6.2	1.2	3.2	5.6	
^t PZL	OEAB or OEBA	AUB	0.5	3.6	6.6	1.5	3.6	6	ns
^t PHZ	OEAB or OEBA	A or B	0.7	3.6	7	1.8	3.6	5.9	
^t PLZ		AUID	0.7	3.5	6.1	1.7	3.5	5.6	ns

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.



SCBS229F - JUNE 1992 - REVISED MAY 1997



PARAMETER MEASUREMENT INFORMATION

NOTES: A. CL includes probe and jig capacitance.

B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.

C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , t_r \leq 2.5 ns, t_f \leq 2.5 ns.

D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing		ickage Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
5962-9557601NXD	OBSOLETE	LQFP	PZ	100		TBD	Call TI	Call TI
SN74ABTH32501PZ	ACTIVE	LQFP	ΡZ	100	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR
SN74ABTH32501PZG4	ACTIVE	LQFP	ΡZ	100	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

Important Information and Disclaimer:The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF SN54ABTH32501, SN74ABTH32501 :

Enhanced Product: SN74ABTH32501-EP

NOTE: Qualified Version Definitions:

• Enhanced Product - Supports Defense, Aerospace and Medical Applications

MECHANICAL DATA

MTQF013A - OCTOBER 1994 - REVISED DECEMBER 1996

PZ (S-PQFP-G100)

PLASTIC QUAD FLATPACK



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MS-026



IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or service without notice. Customers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All products are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

TI assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using TI components. To minimize the risks associated with customer products and applications, customers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any TI patent right, copyright, mask work right, or other TI intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information published by TI regarding third-party products or services does not constitute a license from TI to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alteration is an unfair and deceptive business practice. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

TI products are not authorized for use in safety-critical applications (such as life support) where a failure of the TI product would reasonably be expected to cause severe personal injury or death, unless officers of the parties have executed an agreement specifically governing such use. Buyers represent that they have all necessary expertise in the safety and regulatory ramifications of their applications, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of TI products in such safety-critical applications, notwithstanding any applications-related information or support that may be provided by TI. Further, Buyers must fully indemnify TI and its representatives against any damages arising out of the use of TI products in such safety-critical applications.

TI products are neither designed nor intended for use in military/aerospace applications or environments unless the TI products are specifically designated by TI as military-grade or "enhanced plastic." Only products designated by TI as military-grade meet military specifications. Buyers acknowledge and agree that any such use of TI products which TI has not designated as military-grade is solely at the Buyer's risk, and that they are solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI products are neither designed nor intended for use in automotive applications or environments unless the specific TI products are designated by TI as compliant with ISO/TS 16949 requirements. Buyers acknowledge and agree that, if they use any non-designated products in automotive applications, TI will not be responsible for any failure to meet such requirements.

Following are URLs where you can obtain information on other Texas Instruments products and application solutions:

Products		Applications	
Amplifiers	amplifier.ti.com	Audio	www.ti.com/audio
Data Converters	dataconverter.ti.com	Automotive	www.ti.com/automotive
DSP	dsp.ti.com	Broadband	www.ti.com/broadband
Clocks and Timers	www.ti.com/clocks	Digital Control	www.ti.com/digitalcontrol
Interface	interface.ti.com	Medical	www.ti.com/medical
Logic	logic.ti.com	Military	www.ti.com/military
Power Mgmt	power.ti.com	Optical Networking	www.ti.com/opticalnetwork
Microcontrollers	microcontroller.ti.com	Security	www.ti.com/security
RFID	www.ti-rfid.com	Telephony	www.ti.com/telephony
RF/IF and ZigBee® Solutions	www.ti.com/lprf	Video & Imaging	www.ti.com/video
		Wireless	www.ti.com/wireless

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2008, Texas Instruments Incorporated